

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/790,821	<b>Applicant(s)/Patent under Reexamination</b> NAGANO ET AL.
<b>Examiner</b> (Nancy) Thanh-Nhan P. Nguyen	<b>Art Unit</b> 2871	

## **Search Notes**



## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner